

Search Notes

Application/Control No.

10/702,239

Examiner

TUYEN T. NGUYEN

Applicant(s)/Patent under
Reexamination

BERKCAN ET AL.

Art Unit

2832

SEARCHED

Class	Subclass	Date	Examiner
336	83, 90, 178, 225, 229, 233- 234		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR